



EMC TEST REPORT

Report No.: SET2019-09160

Product Name: LTE UFi

FCC ID: SRQ-MF920U

Model No. : MF920U

Applicant: ZTE Corporation

Address: ZTE Plaza, Keji Road South, Shenzhen, China

Received Date: 2019.07.15

Dates of Testing: 07/15/2019 —07/20/2019

Issued by: CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd.

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Test Report

Product Name..... LTE UFi

Model No. MF920U

Trade name ZTE

Applicant..... ZTE Corporation

Applicant Address..... ZTE Plaza, Keji Road South, Shenzhen, China

Manufacturer ZTE Corporation

Manufacturer Address ZTE Plaza, Keji Road South, Shenzhen, China

Test Standards..... 47 CFR Part 15 Subpart B

Test Result PASS

Tested by Yun Lei Fang

Yun Lei Fang Test Engineer

2019.07.25

Reviewed by Chris You

Chris You Senior Engineer

2019.07.25

Approved by Shuangwen Zhang

Shuangwen Zhang, Manager

2019.07.25

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Change History		
Issue	Date	Reason for change
1.0	2019.07.25	First edition



1. GENERAL INFORMATION

1.1 EUT Description

EUT Name : LTEUFI

Trade Name..... : ZTE

Brand Name..... : ZTE

Hardware Version..... : dwhA

Software Version..... : BD_LAMF920UV1.0.0B01

Note 1: The EUT is a LTEUFI;

Note 2: For a more detailed description, please refer to Specification or User's Manual supplied by the applicant and/or manufacturer.



1.2 Test Standards and Results

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Document Title
1	47 CFR Part 15 Subpart B 2018	Radio Frequency Devices

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Result
1	15.107	Conducted Emission	PASS
2	15.109	Radiated Emission	PASS

NOTE:

(1) The EUT has been tested according to 47 CFR Part 15 Subpart B, Class B. The test procedure is according to ANSI C63.4:2014.



1.3 Facilities and Accreditations

1.3.1 Facilities

FCC-Registration No.: CN5031

CCIC Southern Testing Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. Designation Number: CN5031, valid time is until December 31, 2018.

ISED Registration: 11185A-1, CAB identifier: CN0064

CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd. EMC Laboratory has been registered by Certification and Engineering Bureau of Industry Canada for the performance of radiated measurements with Registration No. 11185A-1 on Aug. 04, 2016, valid time is until Dec. 31, 2019.

NVLAP Lab Code: 201008-0

CCIC-SET is a third party testing organization accredited by NVLAP according to ISO/IEC 17025. The accreditation certificate number is 201008-0.

1.3.2 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15°C - 35°C
Relative Humidity (%):	25% -75%
Atmospheric Pressure (kPa):	86kPa-106kPa

1.3.3 Measurement Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Conducted Emission:	Uc = 3.6 dB (k=2)
Uncertainty of Radiated Emission:	Uc = 4.5 dB (k=2)

2. TEST CONDITIONS SETTING

2.1 Test Peripherals

The following is a listing of the EUT and peripherals utilized during the performance of EMC test:

Support Equipment:

Description	Brand name	Model	Serial No.	FCCID
Notebook	ThinkPad	E430C	A131101550	N/A
Mouse	Logitech	M100r	25011051	DOC

Support Cable:

Description	Shield Type	Ferrite Core	Length
USB Cable	shielding	Yes	1.2m
RJ45 Cable	shielding	No	2m
PC Power adapter Cable	Un- shielding	No	1.2m
Mouse Cable	Un- shielding	No	1m

2.2 Test Mode

The EUT have the following typical setups during the test:

Setup1: EUT(GSM Traffic)+ Mouse + Notebook PC

Setup2: EUT(WCDMA Traffic)+ Mouse + Notebook PC

Setup3: EUT(LTE Traffic)+ Mouse + Notebook PC

Setup4: EUT(WLAN Traffic)+ Mouse + Notebook PC

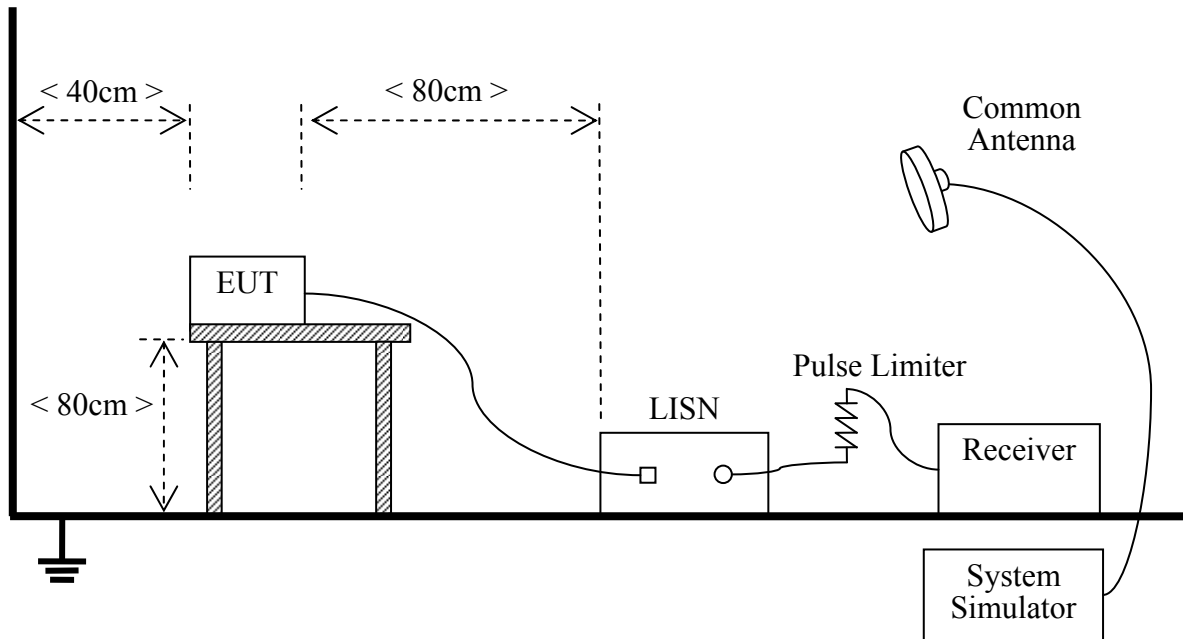
Setup5: EUT+ AC Adapter

Note: only worst-case mode setup 1 mode data provide at the report

2.3 Test Setup and Equipments List

2.3.1 Conducted Emission

A. Test Setup:



The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides 50Ω/50μH of coupling impedance for the measuring instrument. The Common Antenna is used for the call between the EUT and the System Simulator (SS). A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

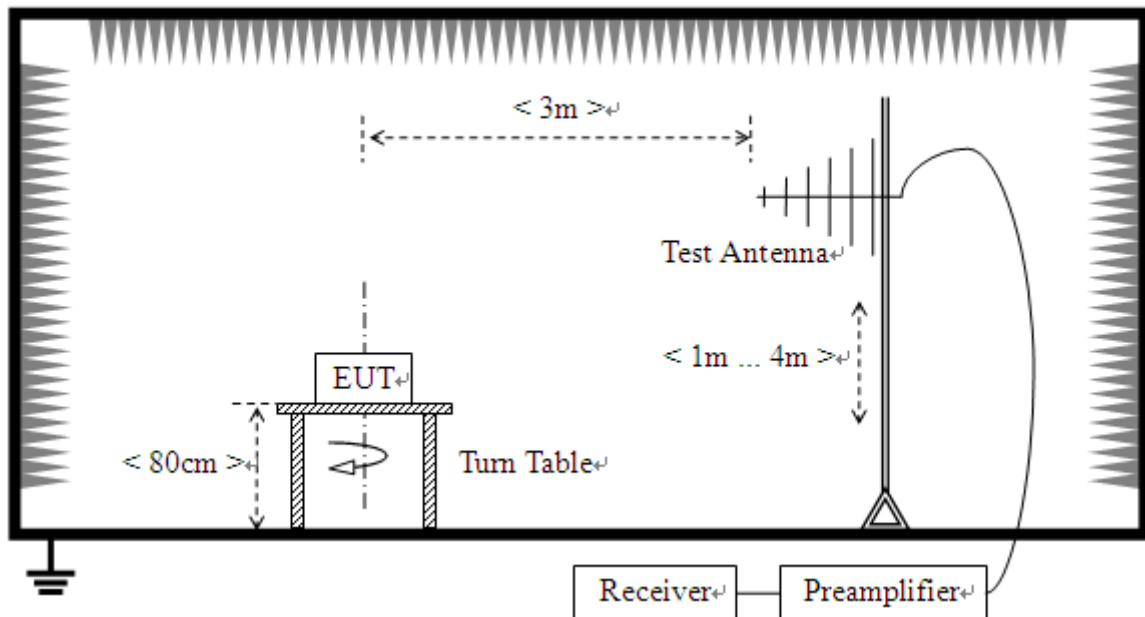
B. Equipments List:

Description	Manufacturer	Model	Serial No.	Calibration Date	Calibration Due. Date
Test Receiver	KEYSIGHT	ESR3	A181103297	2018.09.14	2019.09.13
LISN	ROHDE&SCHWARZ	ENV216	A140701847	2018.12.10	2019.12.10
Cable	MATCHING PAD	W7	/	2019.01.02	2020.01.01

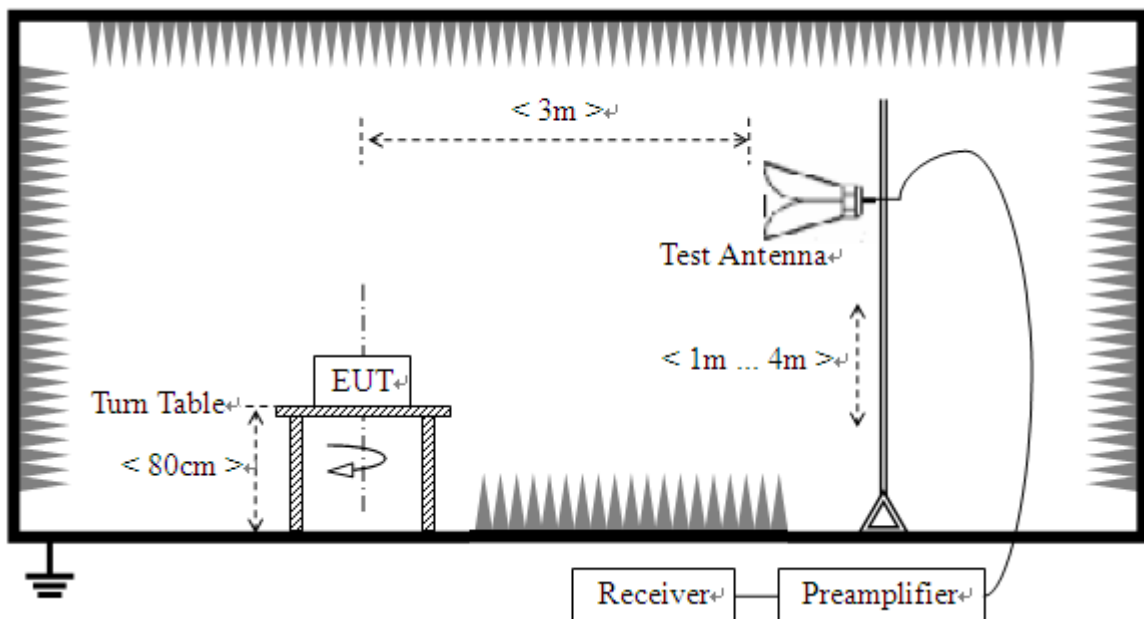
2.3.2 Radiated Emission

A. Test Setup:

- 1) For radiated emissions from 30MHz to 1GHz



2) For radiated emissions above 1GHz



B. Test Procedure

The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a

variable-height antenna master tower.

For the test Antenna:

- 1) In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn Test Antenna (above 1GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

C. Equipments List:

Description	Manufacturer	Model	Serial No.	Calibration Date	Calibration Due. Date
EMI Test Receiver	ROHDE&SCHWARZ	ESR3	A181103297	2018.09.14	2019.09.13
LISN	ROHDE&SCHWARZ	ENV216	A140701847	2018.12.10	2019.12.10
Shield Room	/	L7300*W4500 *H3100	A181003226	2018.09.06	2021.09.05
EMI Test Receiver	ROHDE&SCHWARZ	ESIB7	A0501375	2018.08.06	2019.08.05
Broadband Ant.	2786	ETC	A150402239	2018.09.17	2021.09.16
3M Anechoic Chamber	Albatross	SAC-3MAC 9*6*6m	A0412375	2016.03.08	2020.03.07
EMI Test Receiver	ROHDE&SCHWARZ	ESIB26	A180502935	2018.11.01	2019.10.31
System Simulator	ROHDE&SCHWARZ	CMW500	A150802214	2017.08.29	2019.08.28
5M Anechoic Chamber	Albatross	SAC-5MAC 12.8x6.8x6.4m	A0304210	2016.03.08	2020.03.07
EMI Horn Ant.	ROHDE&SCHWARZ	HF906	A0304225	2019.04.17	2022.04.17

3. 47 CFR PART 15B REQUIREMENTS

3.1 Conducted Emission

3.1.1 Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a 50 μ H/50 Ω line impedance stabilization network (LISN).

Frequency range (MHz)	Conducted Limit (dB μ V)	
	Quasi-peak	Average
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

Note:

- The limit subjects to the Class B digital device.
- The lower limit shall apply at the band edges.
- The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50MHz.

3.1.2 Test Description

See section 2.3.1 of this report.

3.1.3 Test Result

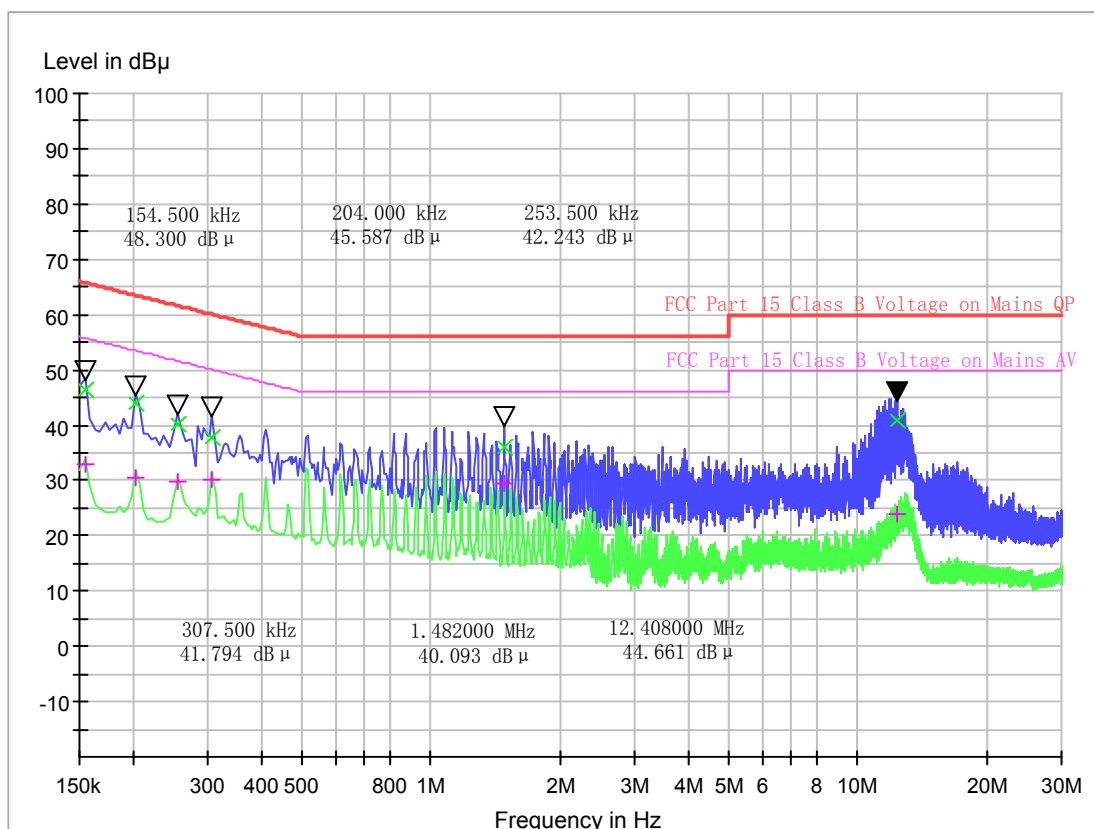
The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

Note:

Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a Nominal 120V AC,50/60Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

Test voltage and frequency (120V AC,60Hz)

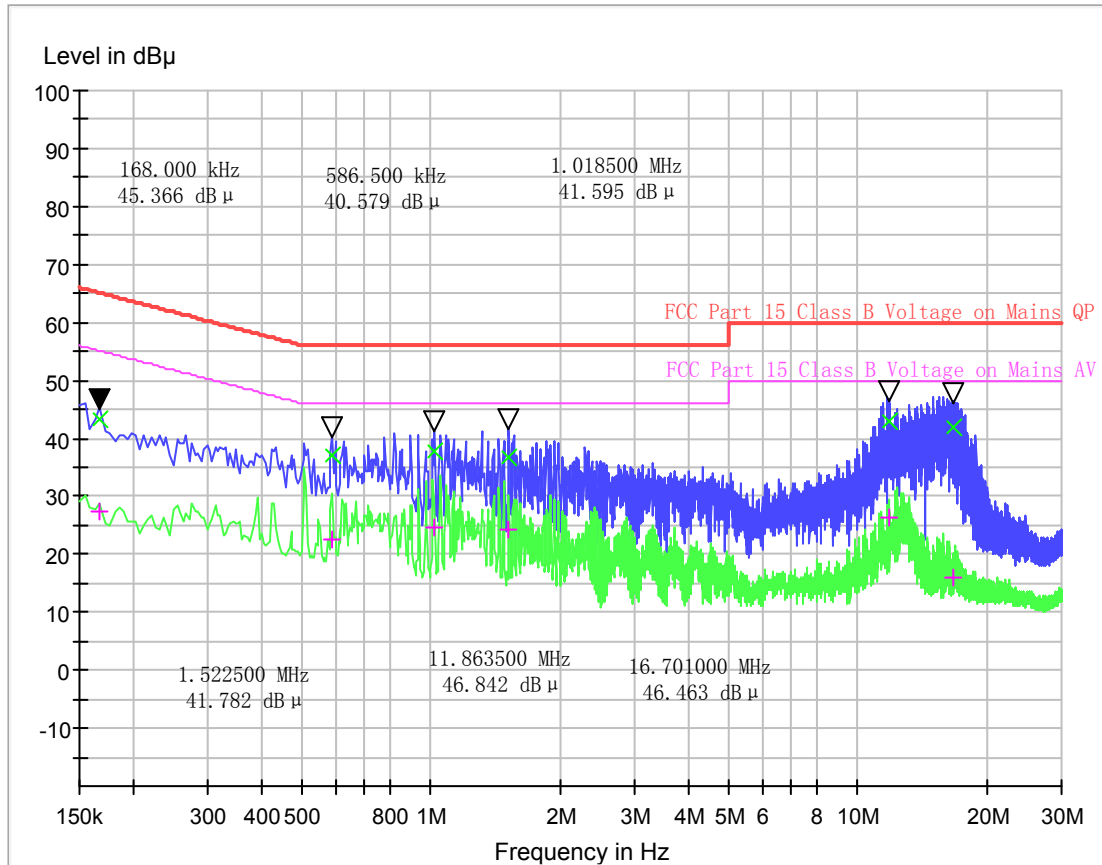
A. Mains terminal disturbance voltage, L phase



(Plot A: L Phase)

Conducted Disturbance at Mains Terminals							
L Test Data							
QP				AV			
Frequency (MHz)	Limits (dBμV)	Measurement Value (dBμV)	Margin (dB)	Frequency (MHz)	Limits (dBμV)	Measurement Value (dBμV)	Margin (dB)
0.1545	65.80	46.50	19.25	0.1545	55.80	32.77	22.98
0.2040	63.40	43.84	19.61	0.2040	53.40	30.40	23.05
0.2535	61.60	40.19	21.45	0.2535	51.60	29.86	21.78
0.3075	60.00	37.78	22.26	0.3075	50.00	30.07	19.97
1.4820	56.00	35.90	20.10	1.4820	46.00	29.41	16.59
12.4080	60.00	40.75	19.25	12.4080	50.00	23.90	26.10

B. Mains terminal disturbance voltage, N phase



(Plot B: N Phase)

Conducted Disturbance at Mains Terminals							
N Test Data							
QP				AV			
Frequency (MHz)	Limits (dBμV)	Measurement Value (dBμV)	Margin (dB)	Frequency (MHz)	Limits (dBμV)	Measurement Value (dBμV)	Margin (dB)
0.1680	65.10	43.33	21.73	0.1680	55.10	27.53	27.53
0.5865	56.00	36.92	19.08	0.5865	46.00	22.45	23.55
1.0185	56.00	37.75	18.25	1.0185	46.00	24.54	21.46
1.5225	56.00	36.59	19.41	1.5225	46.00	24.31	21.69
11.8635	60.00	42.78	17.22	11.8635	50.00	26.31	23.69
16.7010	60.00	42.00	18.00	16.7010	50.00	16.13	33.87

3.2 Radiated Emission

3.2.1 Requirement

According to FCC section 15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency range (MHz)	Field Strength		Field Strength Limitation at 3m Measurement Dist	
	$\mu\text{V/m}$	Dist	($\mu\text{V/m}$)	(dBuV/m)
0.009 - 0.490	$2400/F(\text{kHz})$	300m	$10000 * 2400/F(\text{kHz})$	$20\log 2400/F(\text{kHz}) + 80$
0.490 - 1.705	$2400/F(\text{kHz})$	30m	$100 * 2400/F(\text{kHz})$	$20\log 2400/F(\text{kHz}) + 40$
1.705 - 30.00	30	30m	$100 * 30$	$20\log 30 + 40$
30.0 - 88.0	100	3m	100	$20\log 100$
88.0 - 216.0	150	3m	150	$20\log 150$
216.0 - 960.0	200	3m	200	$20\log 200$
Above 960.0	500	3m	500	$20\log 500$

- As shown in FCC section 15.35(b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.
- Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength.
- For below 1G :QP detector RBW 120kHz ,VBW 300kHz.
- For Above 1G: PK detector RBW 1MHz,VBW 3MHz for PK value ;AV detector RBW 1MHz, VBW 10Hz for AV value.

Note:

- The tighter limit shall apply at the boundary between two frequency range.
- Limitation expressed in dBuV/m is calculated by $20\log \text{Emission Level}(\mu\text{V/m})$.
- If measurement is made at 3m distance, then F.S Limitation at 3m distance is adjusted by using the formula of $Ld1 = Ld2 * (d2/d1)^2$.

Example:

F.S Limit at 30m distance is $30\mu\text{V/m}$, then F.S Limitation at 3m distance is adjusted as

$$Ld1 = L1 = 30\mu\text{V/m} * (10)^2 = 100 * 30\mu\text{V/m}.$$

3.2.2 Test Description

See section 2.3.2 of this report.

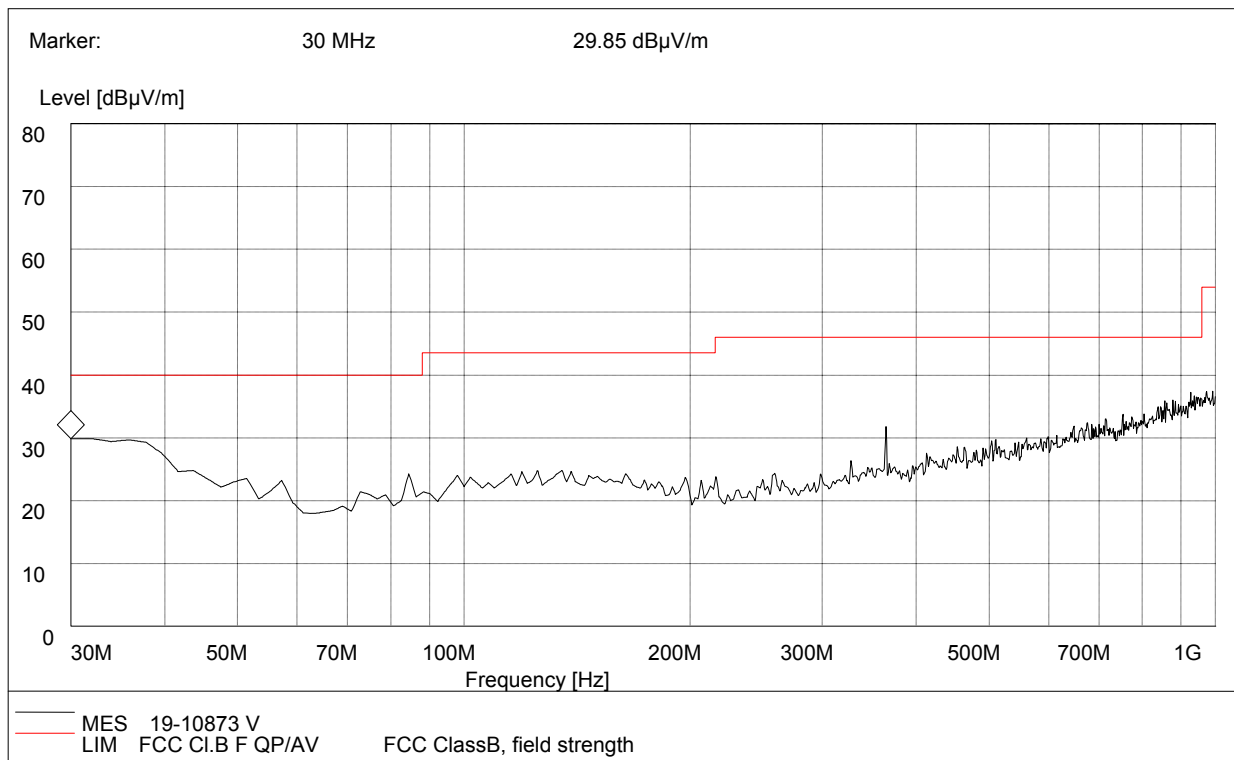
3.2.3 Test Result

The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

The amplitude of spurious emissions which are attenuated more than 20 dB below the permissible value need not be reported.

Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.

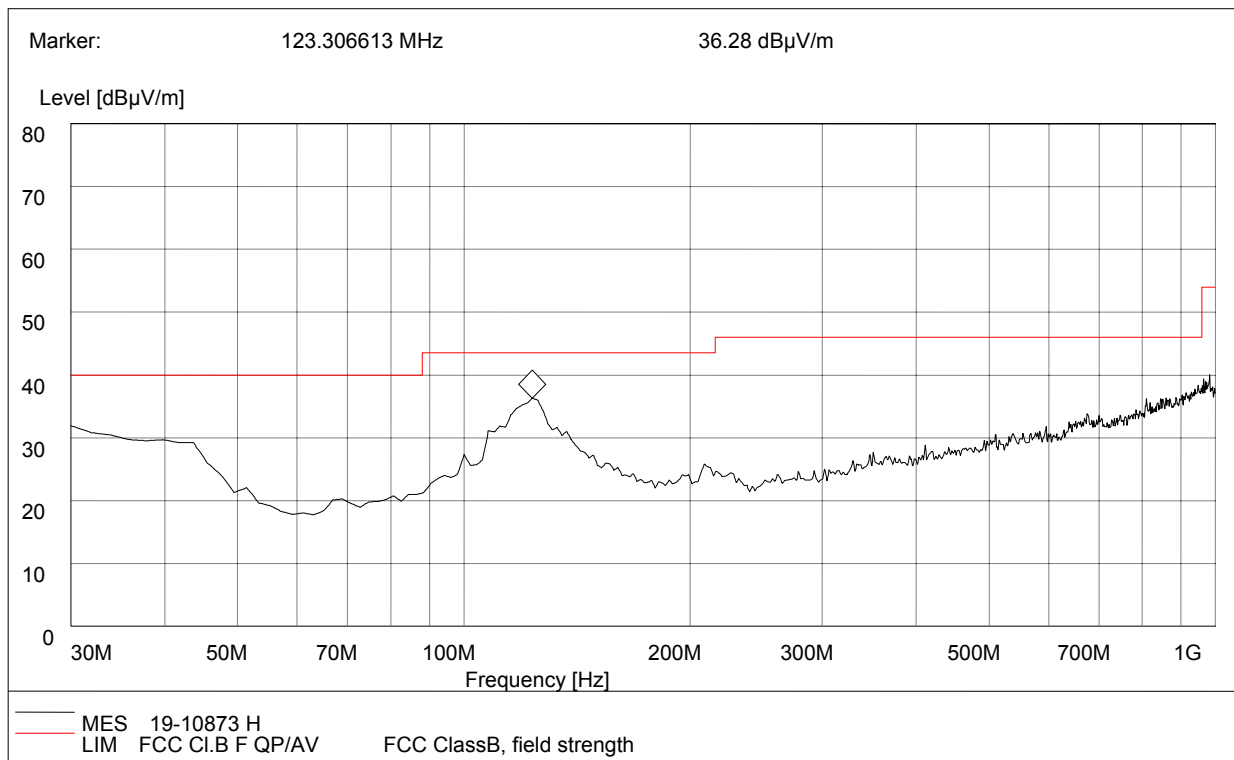
A.Radiation disturbances, antenna polarization:Vertical



(Plot C: Test Antenna Vertical 30M - 1G)

Frequency (MHz)	QuasiPeak (dB μ V/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dB μ V/m)	Margin (dB)	Antenna	Verdict
30.26	30.12	120.000	208.0	40.00	9.88	Vertical	Pass
37.52	28.11	120.000	129.0	40.00	11.89	Vertical	Pass
58.12	20.02	120.000	147.0	40.00	19.98	Vertical	Pass
106.87	23.05	120.000	169.0	43.50	20.45	Vertical	Pass
148.92	22.43	120.000	207.0	43.50	21.07	Vertical	Pass
387.26	30.11	120.000	207.0	46.00	15.89	Vertical	Pass

B.Radiation disturbances, antenna polarization: Horizontal

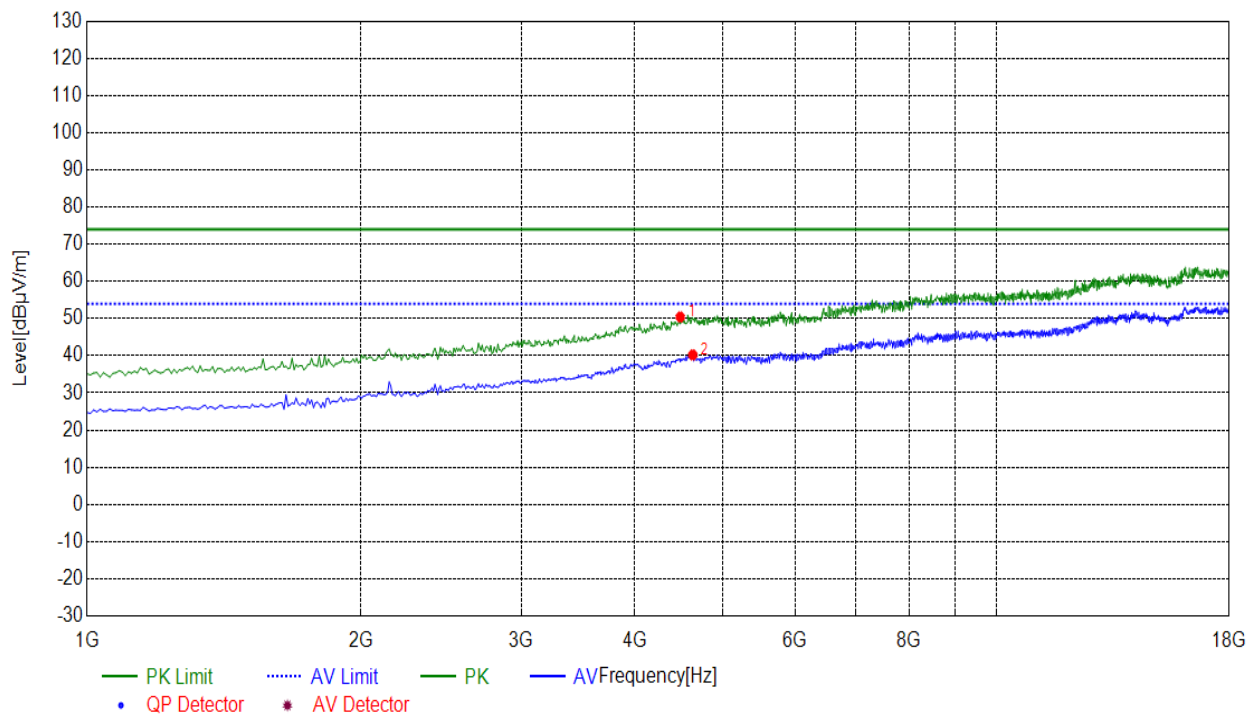


(Plot D: Test Antenna Horizontal 30M - 1G)

Frequency (MHz)	QuasiPeak (dB μ V/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dB μ V/m)	Margin (dB)	Antenna	Verdict
30.00	29.49	120.000	223.0	40.00	10.51	Horizontal	Pass
43.21	24.67	120.000	209.0	40.00	15.33	Horizontal	Pass
51.11	20.14	120.000	126.0	43.50	23.36	Horizontal	Pass
123.31	36.28	120.000	268.0	43.50	7.22	Horizontal	Pass
205.63	23.55	120.000	214.0	43.50	19.95	Horizontal	Pass
256.32	23.48	120.000	364.0	46.00	22.52	Horizontal	Pass

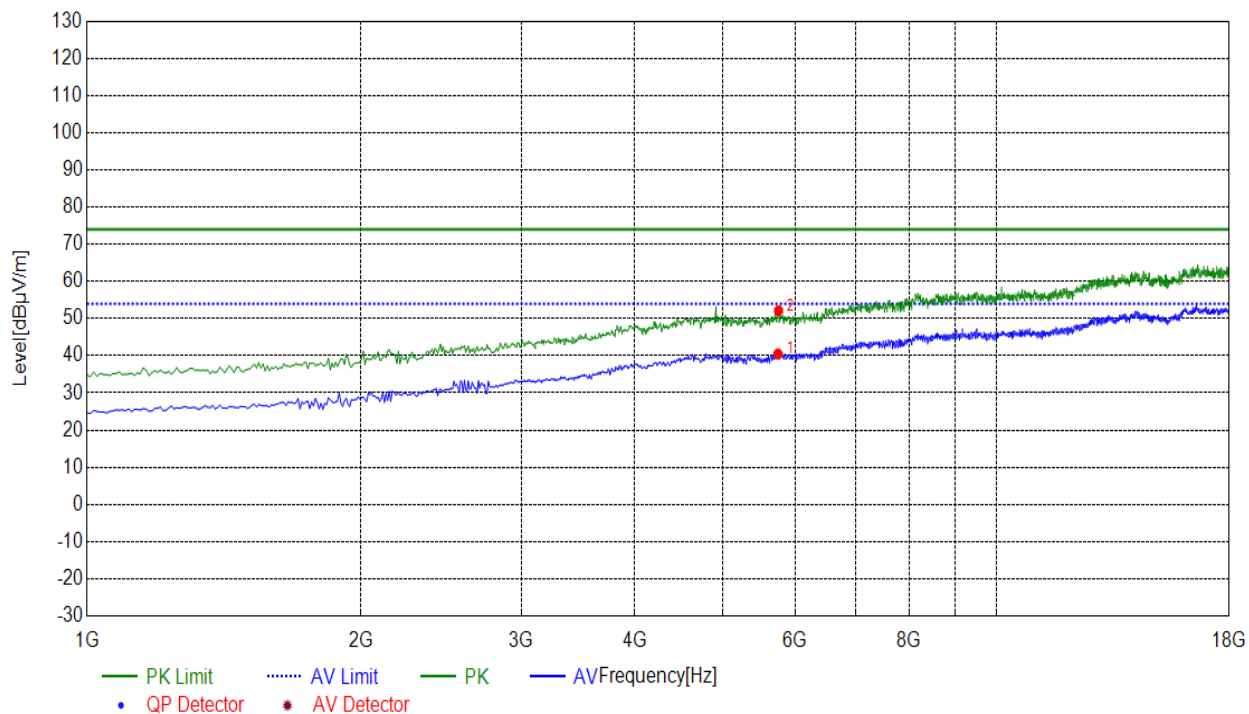
Test Result: PASS

A.Radiation disturbances, antenna polarization: Horizontal



(Plot M: Test Antenna Horizontal 1G – 18G)

B.Radiation disturbances, antenna polarization: Vertical



(Plot N: Test Antenna Vertical 1G – 18G)

-----End of Report-----